LO	YOLA COL	LEGE (AU	ronomous), che	ENNAI – 600 034		
116 200	M.Sc	. DEGREE E	XAMINATION – STA1	TISTICS		
7 F	,	THIRD SEMESTER – APRIL 2014				
LUCEAT LUK VESTER	ST 38 :	l7 - STATIS	TICAL QUALITY CON	ITROL		
Date : 08/04 Time : 01:00	4/2014)-04:00	Dept. No.		Max. : 100 Marks		
		So (Answei	ection – A r all the questions)	(10 x 2 =20)		
1. Define cor	npany-wide qua	lity control.				
2. Define Juran Trilogy						
3. What is downgrading in quality cost.						
4. Write any four considerations in forming lots for inspection.						
5. Give any f	5. Give any five reasons for popularity of the control charts.					
6. What is va	6. What is variable sampling interval?					
7. Express av	7. Express average time to signal.					
8. How to con	8. How to compute one side upper and lower in tabular cusum?					
9. Define six sigma.						
10. What is mo	eant by operatin	g characteristic	curve?			
		S (Answer	ection – B any five questions)	(5 x 8 =40)		
11. Explain the focus of standard in the quality system.						
12. Discuss the rational sub-groups concept.						
13. Describe I	Defect Concentr	ation Diagram.				
14. Explain the	e construction o	f S chart and S	² chart.			
15. Write the disadvantages of V-mask procedure.						
16. What are the choice between attributes and variable control charts?						
17. Explain pr	ocess capability	analysis using	histogram.			
18. Write note	18. Write notes on the following					
1) AQ	ζL IND					
n) LT	PD N					
III) RQ	ίΓ Λ					
ıv) LQ	ĮL.					
		Section -	- C			

(Answer any two questions)

19. Describe the important frame work for implementing quality and productivity improvement.

20. a) Express cumulative sum control chart and tabular cumulative sum control chart.

b) Validate whether the process is under control using tabular cumulative sum control chart for the following data (8+12)

()				
Sub group i	Xi			
1	12.33			
2	9.78			
3	12.98			
4	12.54			
5	15.87			
6	13.56			
7	12.24			
8	14.87			
9	12.66			
10	13.81			
11	12.20			
12	14.83			
13	12.90			
14	13.91			
15	14.45			

21. a) Explicate the OC curve in double sampling plan for attributes.b) Discuss sequential sampling plans. (10+10)

22. a) Elucidate process capability ratios for an off-center process.

b) Describe the process capability analysis using \bar{X} and R charts. (10+10)